Se	arcn	notes	

Application/Control No.	Applicant(s)/Patent under Reexamination
10/630,054	YANG ET AL.
Examiner	_ Art Unit
Alvin T. Raetzsch	1754

SEARCHED					
Class	Subclass	Date	Examiner		
. 423	447.3	10/21/2005	ATR		
423	447.3	4/19/06	AR		
423 502	447.3 313 314	1			
	310	*	*		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
see attached	10/21/2005	ATR
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